

## Supporting Information

### Highly Efficient and Stable Inverted Perovskite Solar Cells Using Down-Shifting Quantum Dots as a Light Management Layer and Moisture-Assisted Film Growth

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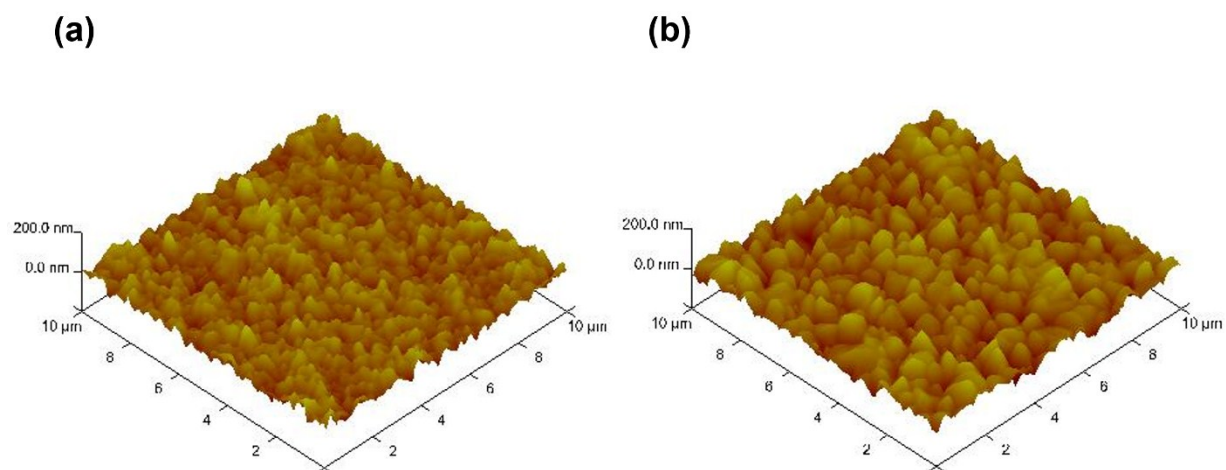
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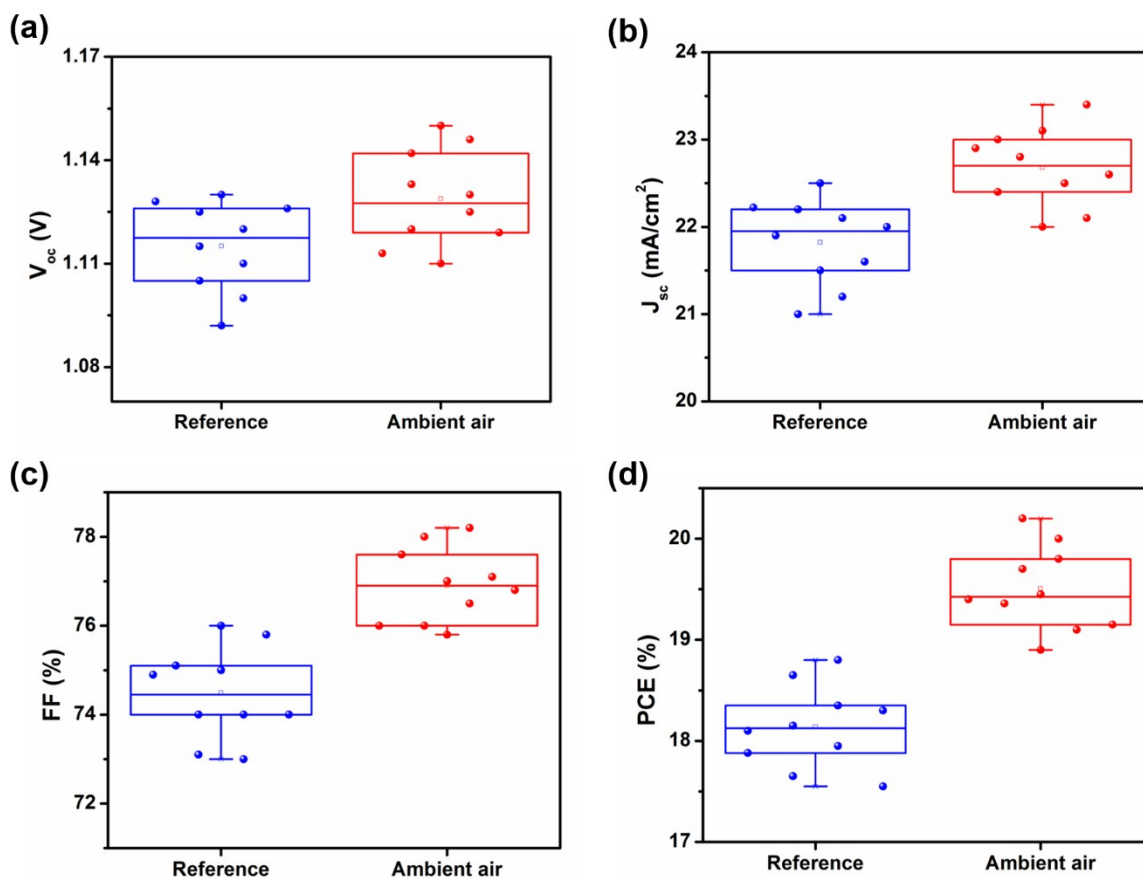
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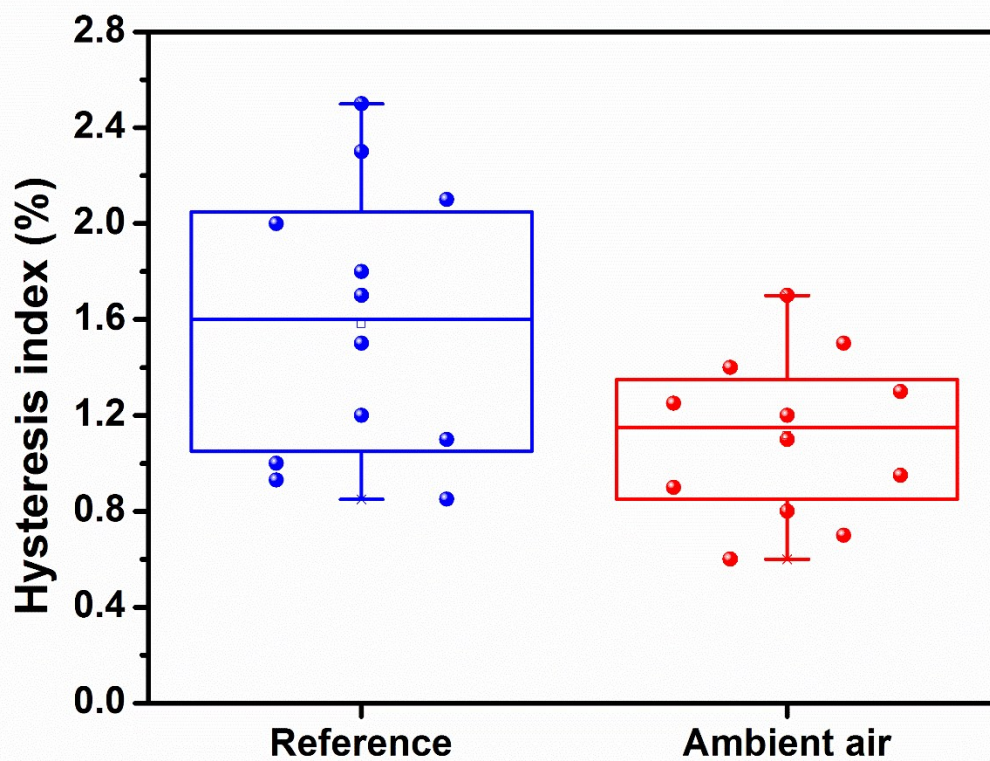
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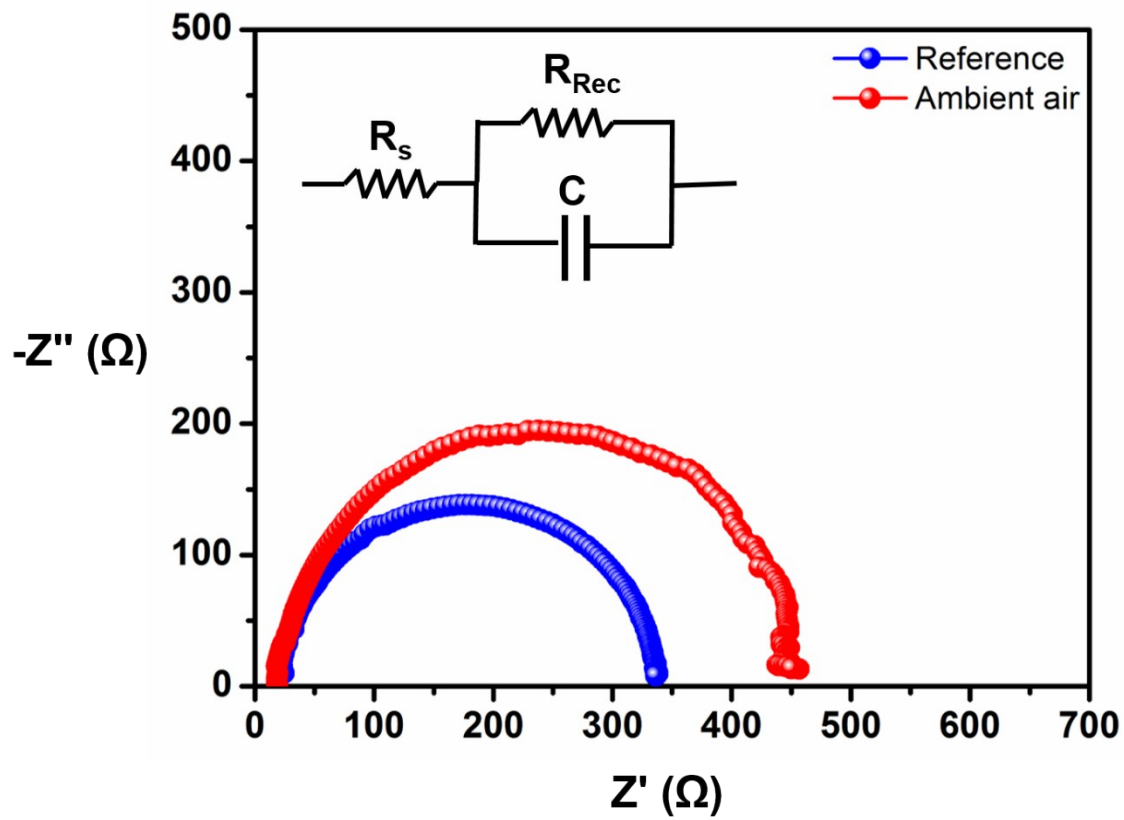
**Figure S1.** Three-dimensional AFM images of perovskite films annealed inside the glovebox (a) and (b) ambient air.



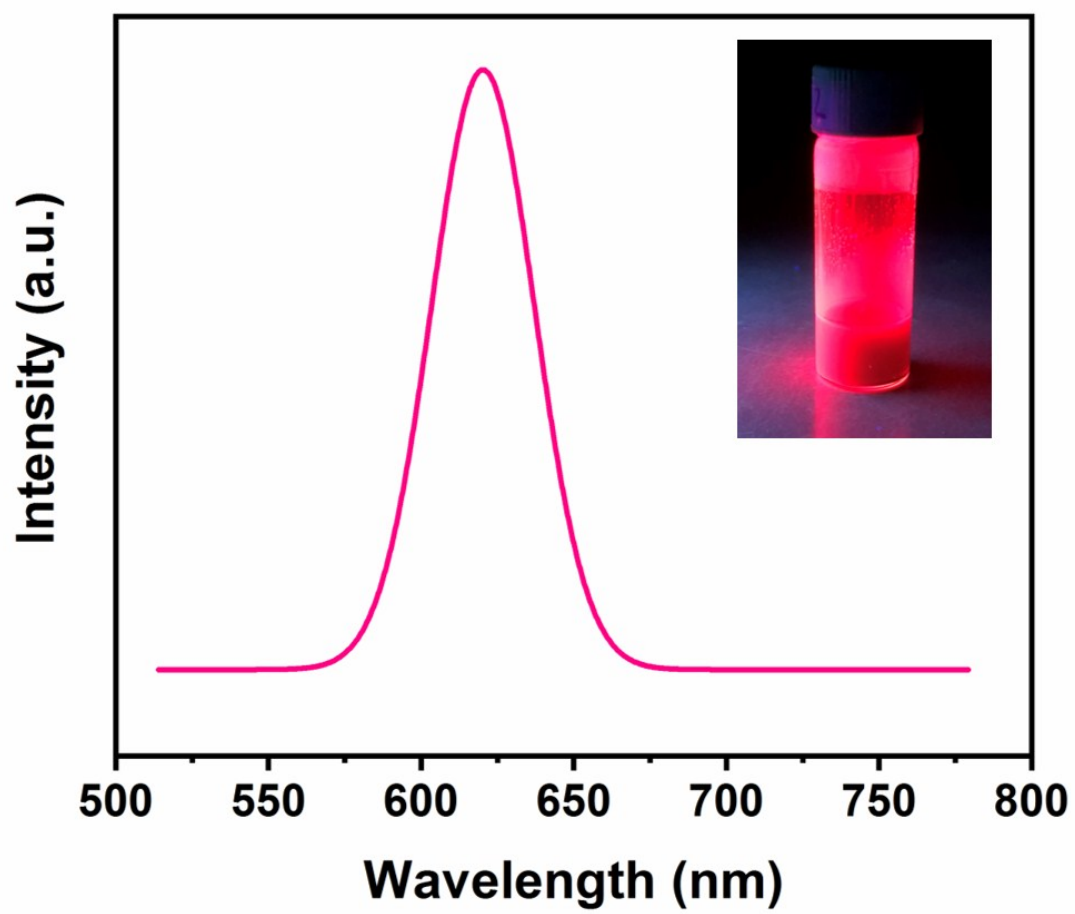
**Figure S2.** Statistic of the photovoltaic parameters for the PSC devices annealed in nitrogen glovebox (n = 10) and ambient air (n = 10).



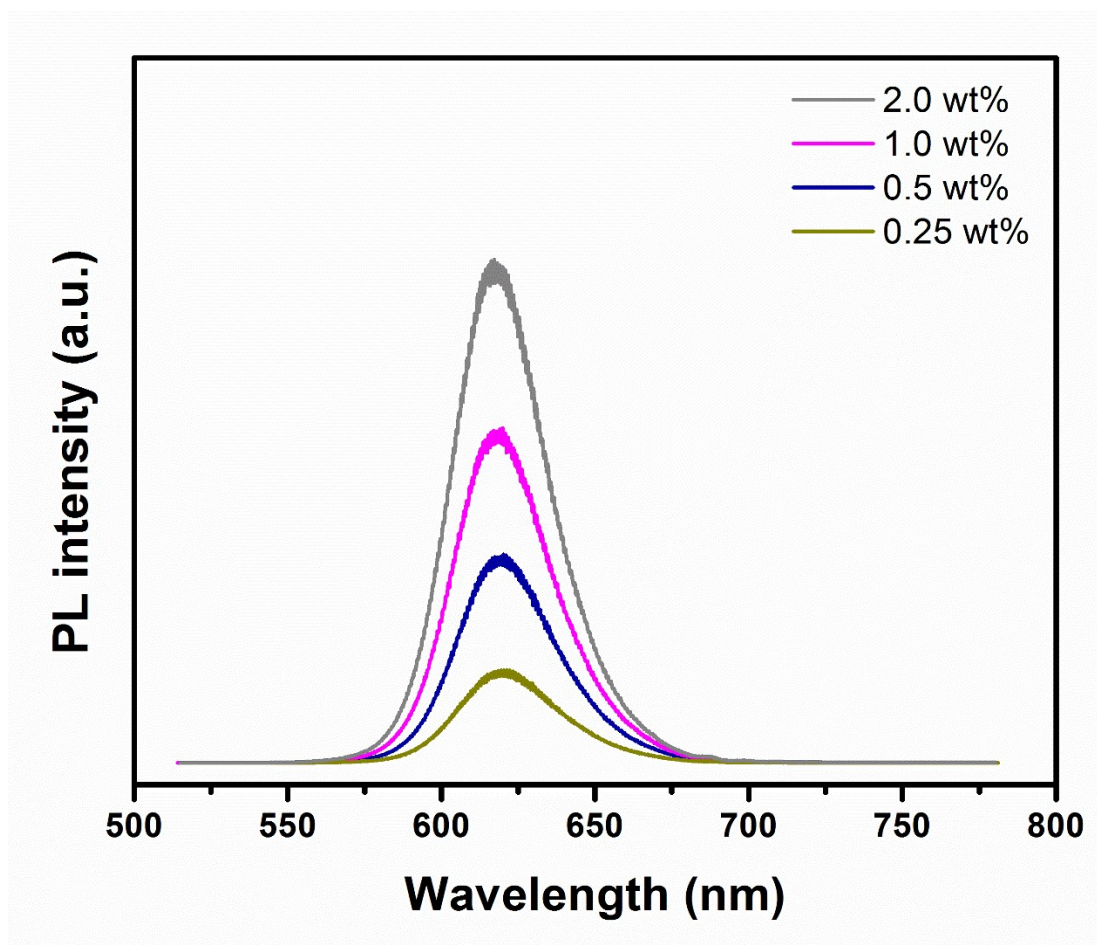
**Figure S3.** Statistic of hysteresis indices for the PSC devices annealed in nitrogen glovebox ( $n = 12$ ) and ambient air ( $n = 12$ ).



**Figure S4.** Nyquist plots of the reference device and modified PSC by annealing the perovskite film in ambient air under dark condition.



**Figure S5.** PL emission for a thin layer of CdSe/CdS QDs deposited on glass.



**Figure S6.** PL emission of the CdSe/CdS QDs layers with different thicknesses deposited on glass substrates.

**Table S1.** Fitting parameters of the TRPL measurement for the perovskite samples deposited on glass

Sample	$A_1$	$\tau_1$ (ns)	$A_2$	$\tau_2$ (ns)	$A_3$	$\tau_3$ (ns)
Reference	0.164	3.39	0.3	24.1	0.56	78.75
Ambient air	0.049	7.36	0.384	68.74	0.52	179.7

**Table S2.** Figures of merit for the PSC devices including down-shifting layers with different concentrations (These data are the average value of 10 PSC devices)

Concentration (wt%)	$V_{oc}$ (mV)	$J_{sc}$ (mA/cm <sup>2</sup> )	FF (%)	PCE (%)
<b>0</b>	<b>1130±17</b>	<b>22.7±0.4</b>	<b>77±1.1</b>	<b>19.4±0.7</b>
<b>0.25</b>	<b>1130±15</b>	<b>22.8±0.4</b>	<b>77±1.2</b>	<b>19.75±0.7</b>
<b>0.5</b>	<b>1130±17</b>	<b>22.9±0.5</b>	<b>77±1.3</b>	<b>19.86±0.7</b>
<b>1.0</b>	<b>1131±16</b>	<b>23±0.6</b>	<b>77.1±1.3</b>	<b>19.9±0.8</b>
<b>2.0</b>	<b>1131±18</b>	<b>22.3±0.3</b>	<b>76±1.2</b>	<b>19.1±0.6</b>